

Notice of References Cited	Application/Control No. 09/974,878	Applicant(s)/Patent Under Reexamination HOTTA ET AL.	
	Examiner Diem Tran	Art Unit 3748	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5332554	07-1994	Yasaki et al.	60/299
	B	US-5939028	08-1999	Bennett et al.	60/297
	C	US-5397550	03-1995	Marino, Jr.	422/178
	D	US-5447694	09-1995	Swaroop et al.	422/171
	E	US-6029441	02-2000	Mizuno et al.	60/289
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP6319948	11-1994	Japan	Masahiro et al.	
	O	JP2001303939	10-2001	Japan	Hideo et al.	
	P	JP409103645	04-1997	Japan	Frost et al.	
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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	U	
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	X	

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Diem Tran

Art Unit

3748

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,477,831	11-2002	Ballinger et al.	60/299
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
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	J	US-			
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